

CE EMC TEST REPORT

On Behalf of

Product Name: Power Quality Optimizer

Trademark: N/A

Model Number: T200, T65, T100, T300, T400, T500, S15, S35, S50, S65, S100.

Prepared For: VSCIEN LIGHT TECHNOLOGY CO.,LTD

Address: 5F West 4 Building,Hengmingzhu Industrial Park,Shajing street,Bao an District,Shenzhen,Guangdong

Prepared By: Shenzhen BKC Testing Co., Ltd.

Address: 103, 1/F, Huaya Science Park, Longhua Community, Longhua District, Shenzhen, Guangdong, China.

Test Date: Apr. 29, 2022 to May 11, 2022

Date of Report : May 11, 2022

Report Number: BKC22041230EE



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Shenzhen BKC Testing Co., Ltd.

Applicant : VSCIEN LIGHT TECHNOLOGY CO.,LTD
Address : 5F West 4 Building,Hengmingzhu Industrial Park,Shajing street,Bao an District,Shenzhen,Guangdong
Manufacturer : VSCIEN LIGHT TECHNOLOGY CO.,LTD
Address : 5F West 4 Building,Hengmingzhu Industrial Park,Shajing street,Bao an District,Shenzhen,Guangdong
Product Name : Power Quality Optimizer
Model Number : T200
Trademark : N/A
Test Date : Apr. 29, 2022 to May 11, 2022
Date of Report : May 11, 2022
Test Result : The equipment under test was found to be compliance with the requirements of the standards applied.
Test Procedure Used:
EMI : EN 55032:2015+A11:2020+A1:2020
EN IEC 61000-3-2:2019+A1:2021, EN 61000-3-3:2013+A1:2019
EMS : EN 55035:2017+A11:2020
EN 61000-4-2:2009, EN IEC 61000-4-3:2020,
EN 61000-4-4:2012, EN 61000-4-5:2014+A1:2017,
EN 61000-4-6:2014, EN 61000-4-8:2010, EN IEC 61000-4-11:2020

Prepared by(Test Engineer):
Zoro Huang



Reviewer(Supervisor):
Corbin Wang



Approved(Manager):
Levi Xiao



1. GENERAL INFORMATION

1.1. Description of Device (EUT)

EUT : Power Quality Optimizer

Trademark : N/A

Model Number : T200

Model Difference : The product is different for model name and outlook color.

Power Supply : Input: 380-415V~ 3PH 50/60Hz 0-500A
Output: 380-415V~ 50/60Hz 0-500A

Work Frequency : Below 108MHz

Note:

- 1) EUT: Equipment under test
- 2) T200 was selected as the test model and the datas have been recorded in this report.

1.2. Tested System Details

Personal Computer	: DELL	Monitor	: SONY
M/N	: INSPIRON	M/N	: MNT1
Printer	: EPSON STYLUS	Keyboard (USB)	: Genuine
M/N	: P320A	M/N	: N/A
Modem	: ACEEX	Mouse	: DETROIS
M/N	: DM-1414	M/N	: CM309

1.3. Test Uncertainty

Conducted Emission Uncertainty : $\pm 2.48\text{dB}$

Radiated Emission Uncertainty : $\pm 4.14\text{dB}$

1.4. Test Facility

Site Description

Name of Firm : Shenzhen BKC Testing Co., Ltd.

Site Location : 103, 1/F, Huaya Science Park, Longhua Community,
Longhua District, Shenzhen, Guangdong, China.



2. TEST INSTRUMENT USED

2.1 CONDUCTED TEST SITE

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	LISN	R&S	ENV216	101313	Nov. 07. 2022
2	LISN	EMCO	3816/2	00042990	Nov. 07. 2022
3	50Ω Switch	ANRITSU CORP	MP59B	6200983704	Nov. 07. 2022
4	EMI Test Receiver	R&S	ESCI	101160	Nov. 07. 2022
5	Passive Voltage Probe	ESH2-Z3	R&S	100196	Nov. 07. 2022
6	Triple-Loop Antenna	EVERFINE	LIA-2	11020003	Nov. 07. 2022
7	Absorbing Clamp	R&S	MDS-21	100423	Nov. 07. 2022
8	Coupling/ Decoupling Network	PH	ISN T800	S1509001	Nov. 07. 2022

2.2 RADIATED TEST SITE

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Bilog Antenna	TESEQ	CBL6111D	31216	Nov. 07. 2022
2	EMI Test Receiver	R&S	ESCI-7	101318	Nov. 07. 2022
3	Antenna Mast	EM	SC100_1	N/A	Nov. 07. 2022
4	50Ω Switch	Anritsu Corp	MP59B	6200983705	Nov. 07. 2022
5	Spectrum Analyzer	Aglient	E4407B	MY45108040	Nov. 07. 2022
6	Horn Antenna	EM	EM-AH-1018 0	2011071402	Nov. 07. 2022
7	Amplifier	EM	EM-30180	060538	Nov. 07. 2022

2.3 HARMONICS AND FLICKER

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Harmonic & Flicker	EM TEST	DPA500	0303-04	Nov. 07. 2022
2	AC Power Source	EM TEST	ACS500	0203-01	Nov. 07. 2022

2.4 Electrostatic Discharge

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	ESD TEST GENERATOR	EVERFINE	EMS61000-2 A-V200	11040001T	Nov. 07. 2022

2.5 RS

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Signal Generator	R&S	SMT 06	832080/007	Nov. 07. 2022
2	Log-Bicon Antenna	Schwarzbeck	VULB9161	4022	Nov. 07. 2022
3	Power Amplifier	AR	150W1000M1	320946	Nov. 07. 2022
4	Microwave Horn Antenna	AR	AT4002A	321467	Nov. 07. 2022
5	Power Amplifier	AR	25S1G4A	308598	Nov. 07. 2022

2.6 SURGE, EFT/BURST, VOLTAGE INTERRUPTION/DIPS

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Surge Generator	EVERFINE	EMS61000-5 A	1101002	Nov. 07. 2022
2	DIPS Generator	EVERFINE	EMS61000-11 K	1011002	Nov. 07. 2022
3	EFT/B Generator	Schaffner	MODULA615 0	34437	Nov. 07. 2022

2.7 INJECTION CURRENT

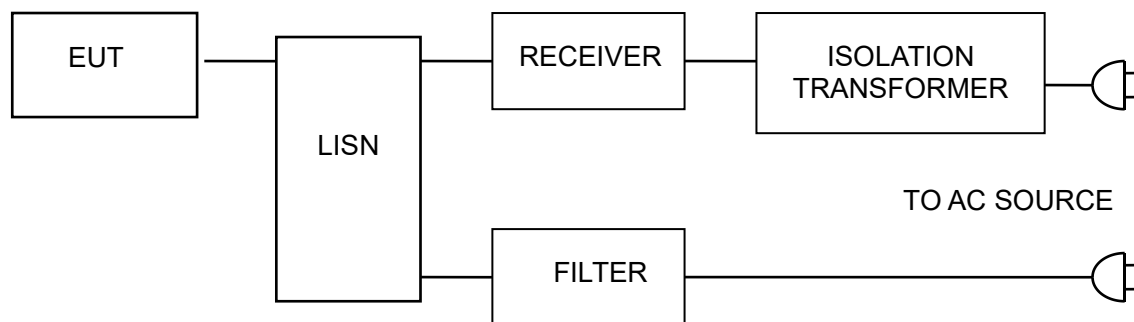
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Signal Generator	IFR	2023A	202301/368	Nov. 07. 2022
2	Power Amplifier	AR	75A250AM1	0320709	Nov. 07. 2022
3	CDN	FCC	FCC-801-M2	06043	Nov. 07. 2022
4	EM Clamp	FCC	F-203I-23MM	504	Nov. 07. 2022

2.8 Magnetic Field Immunity

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Generator	EVERFINE	EMS61000-8 K	1007001	Nov. 07. 2022

3. CONDUCTED EMISSION AT THE MAINS TERMINALS TEST

3.1. Block Diagram Of Test Setup



3.2. Test Standard

EN 55032:2015+A11:2020+A1:2020

3.3. Power Line Conducted Emission Limit

Frequency MHz	Limits dB(μV)	
	Quasi-peak Level	Average Level
0.15 ~ 0.50	66 ~ 56*	56 ~ 46*
0.50 ~ 5.00	56	46
5.00 ~ 30.00	60	50

Notes: 1. *Decreasing linearly with logarithm of frequency.

2. The lower limit shall apply at the transition frequencies.

3.4. EUT Configuration on Test

The following equipments are installed on conducted emission test to meet EN 55032 requirement and operating in a manner which tends to maximize its emission characteristics in a normal application.

3.5. Operating Condition of EUT

3.5.1 Setup the EUT and simulators as shown in Section 3.1.

3.5.2 Turn on the power of all equipments.

3.5.3 Let the EUT work in test modes and test it.

3.6. Test Procedure

The EUT is put on the ground and connected to the AC mains through a Artificial Mains Network (AMN). This provided a 50ohm coupling impedance for the tested equipments. Both sides of AC line are checked to find out the maximum conducted emission levels according to the EN 55032 regulations during conducted emission test.

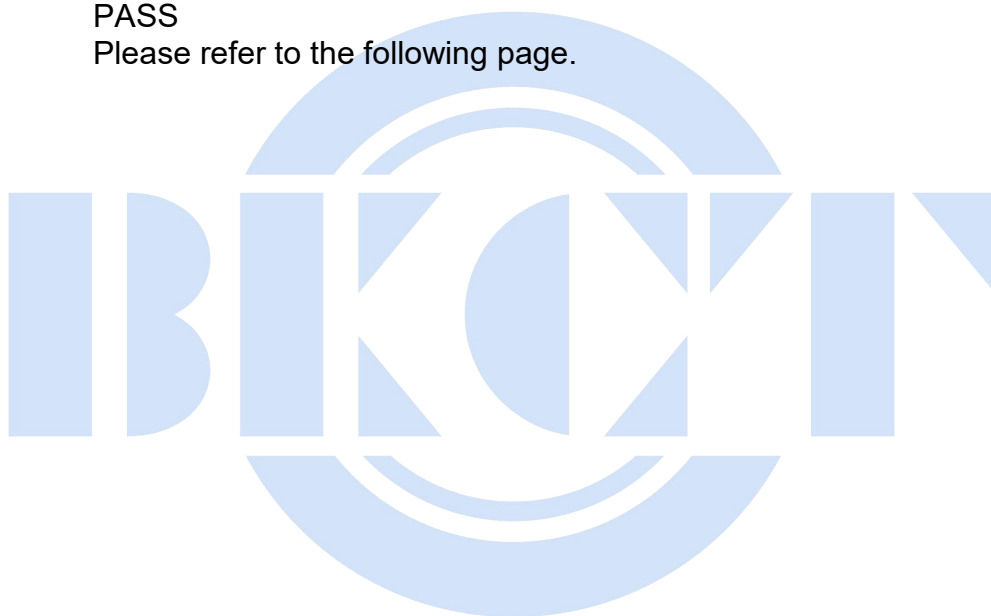
The bandwidth of the test receiver (R&S Test Receiver ESCI) is set at 10KHz.

The frequency range from 150 KHz to 30 MHz is investigated.

3.7. Test Result

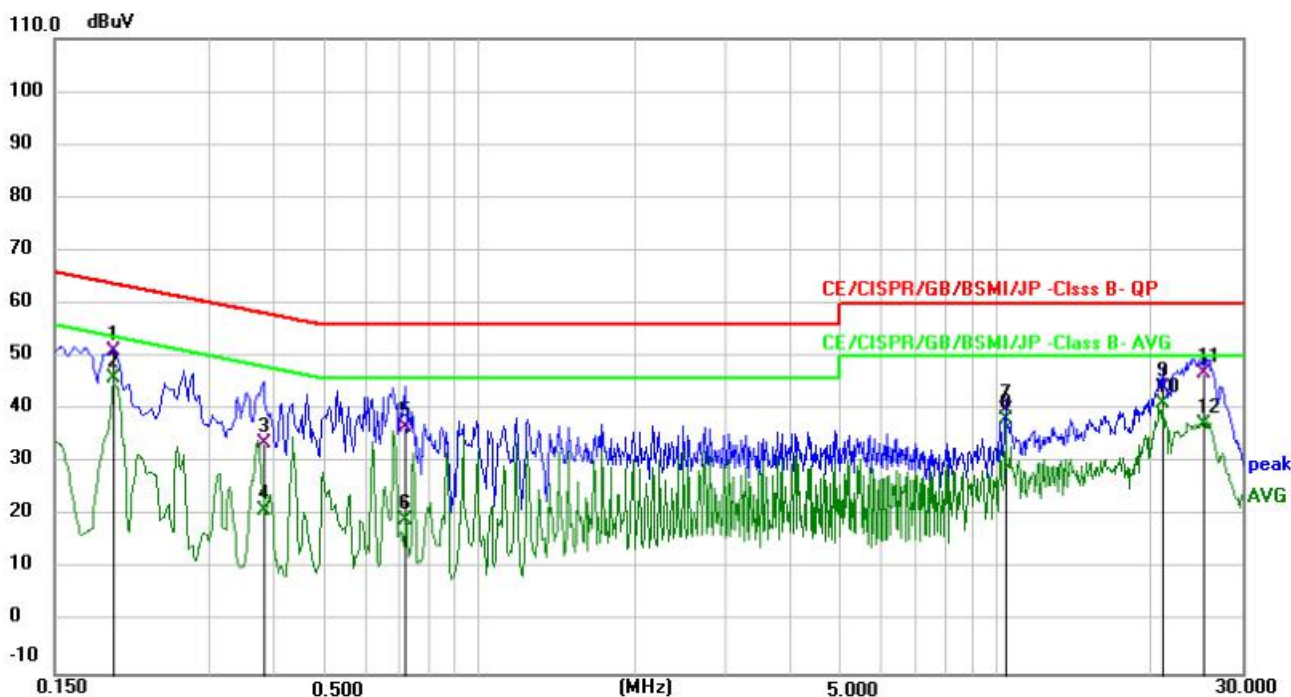
PASS

Please refer to the following page.



Conducted Emission At The Mains Terminals Test Data

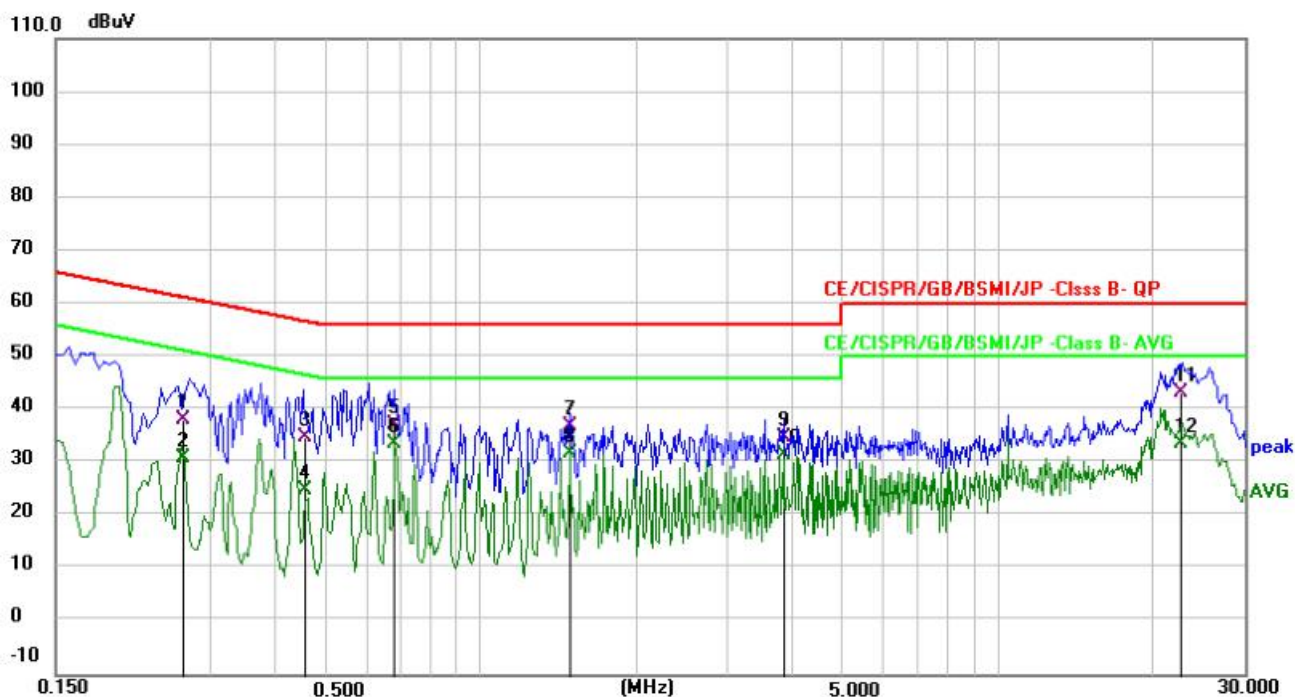
Temperature:	25.1°C	Relative Humidity:	56%
Pressure:	1008hPa	Phase :	Line
Test Voltage :	AC 230V/50Hz	Test Mode:	ON Mode



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F	Remark
1	0.195800	41.06	10.00	51.06	63.79	-12.73	QP	P	
2 *	0.195800	36.01	10.00	46.01	53.79	-7.78	AVG	P	
3	0.382600	23.71	10.00	33.71	58.22	-24.51	QP	P	
4	0.382600	10.98	10.00	20.98	48.22	-27.24	AVG	P	
5	0.719700	26.55	10.00	36.55	56.00	-19.45	QP	P	
6	0.719700	9.39	10.00	19.39	46.00	-26.61	AVG	P	
7	10.406600	29.94	10.00	39.94	60.00	-20.06	QP	P	
8	10.406600	28.01	10.00	38.01	50.00	-11.99	AVG	P	
9	21.116700	34.09	10.00	44.09	60.00	-15.91	QP	P	
10	21.116700	31.11	10.00	41.11	50.00	-8.89	AVG	P	
11	25.348200	36.72	10.00	46.72	60.00	-13.28	QP	P	
12	25.348200	27.12	10.00	37.12	50.00	-12.88	AVG	P	

Conducted Emission At The Mains Terminals Test Data

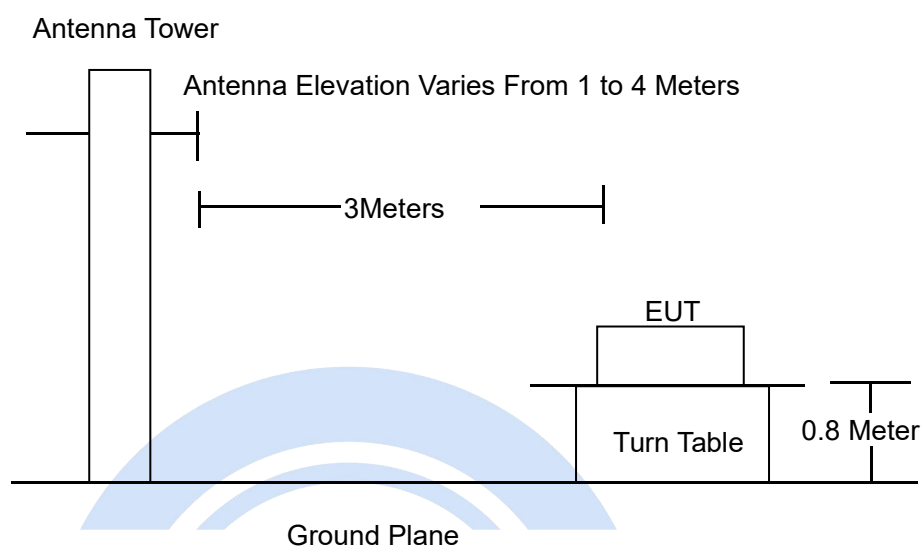
Temperature:	25.1°C	Relative Humidity:	56%
Pressure:	1008hPa	Phase :	Neutral
Test Voltage :	AC 230V/50Hz	Test Mode:	ON Mode



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F	Remark
1	0.265300	28.13	10.00	38.13	61.26	-23.13	QP	P	
2	0.265300	20.98	10.00	30.98	51.26	-20.28	AVG	P	
3	0.458000	24.91	10.00	34.91	56.73	-21.82	QP	P	
4	0.458000	14.82	10.00	24.82	46.73	-21.91	AVG	P	
5	0.680700	27.21	10.00	37.21	56.00	-18.79	QP	P	
6 *	0.680700	23.67	10.00	33.67	46.00	-12.33	AVG	P	
7	1.486700	26.93	10.00	36.93	56.00	-19.07	QP	P	
8	1.486700	21.89	10.00	31.89	46.00	-14.11	AVG	P	
9	3.841500	24.79	10.00	34.79	56.00	-21.21	QP	P	
10	3.841500	21.70	10.00	31.70	46.00	-14.30	AVG	P	
11	22.706600	33.22	10.00	43.22	60.00	-16.78	QP	P	
12	22.706600	23.52	10.00	33.52	50.00	-16.48	AVG	P	

4. RADIATION EMISSION TEST

4.1. Block Diagram of Test Setup



4.2. Test Standard

EN 55032:2015+A11:2020+A1:2020

4.3. Radiation Limit

Frequency MHz	Distance (Meters)	Field Strengths Limits dB(μ V)/m	Detector
30 ~ 230	3	40.0	QP
230 ~ 1000	3	47.0	QP
1000 ~ 3000	3	76.0	PEAK
1000 ~ 3000	3	56.0	AVERAGE
3000 ~ 6000	3	80.0	PEAK
3000 ~ 6000	3	60.0	AVERAGE

Remark:

- (1) Emission level (dB(μ V)/m) = 20 log Emission level (μ V/m)
- (2) The smaller limit shall apply at the cross point between two frequency bands.
- (3) Distance refers to the distance in meters between the measuring instrument, antenna and the closed point of any part of the device or system.

4.4.EUT Configuration on Test

The EN 55032 regulations test method must be used to find the maximum emission during radiated emission test.

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.2.

4.5.Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.2 except the test set up replaced as Section 4.1.

4.6.Test Procedure

The EUT and its simulators are placed on a turned table that is 0.8 meter above the ground. The turned table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna that is mounted on the antenna tower. The antenna can move up and down between 1 meter and 4 meters to find out the maximum emission level. Broadband antenna (calibrated biconical and log periodical antenna) is used as receiving antenna. Both horizontal and vertical polarization of the antenna is set on test. In order to find the maximum emission levels, the interface cable must be manipulated according to EN 55032 on radiated emission test.

The bandwidth setting on the field strength meter (R&S Test Receiver ESCI) is set at 120KHz below 1GHz, set at 1MHz above 1GHz

The frequency range from 30MHz to 1000MHz is checked.

4.7.Test Result

PASS

Please refer to the following page.

Radiation Emission Test Data

Temperature:	25.1°C	Relative Humidity:	56%
Pressure:	1008hPa	Phase :	Horizontal
Test Voltage :	AC 230V/50Hz	Test Mode:	On Mode



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Azimuth (deg.)	P/F	Remark
1	88.0329	52.57	-19.80	32.77	40.00	-7.23	peak	100	82	P	
2 !	113.3162	52.05	-17.61	34.44	40.00	-5.56	peak	100	82	P	
3	142.3243	48.63	-15.57	33.06	40.00	-6.94	peak	100	219	P	
4 *	184.4898	52.06	-17.42	34.64	40.00	-5.36	peak	100	247	P	
5	273.2340	50.97	-15.28	35.69	47.00	-11.31	peak	100	176	P	
6	374.6225	48.49	-12.69	35.80	47.00	-11.20	peak	100	226	P	

Radiation Emission Test Data

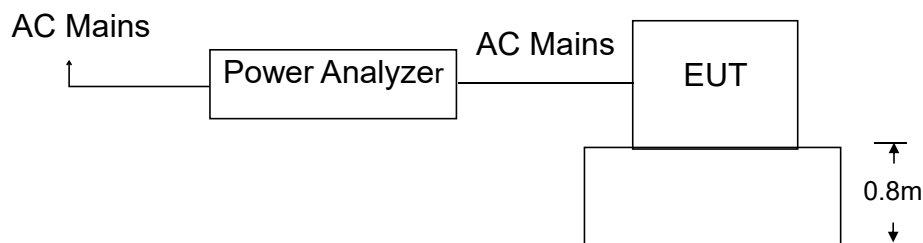
Temperature:	25.1°C	Relative Humidity:	56%
Pressure:	1008hPa	Phase :	Vertical
Test Voltage :	AC 230V/50Hz	Test Mode:	On Mode



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Azimuth (deg.)	P/F	Remark
1	67.4381	48.67	-17.08	31.59	40.00	-8.41	peak	100	1	P	
2 *	91.8161	51.49	-19.59	31.90	40.00	-8.10	peak	100	219	P	
3	147.4036	46.34	-15.46	30.88	40.00	-9.12	peak	100	284	P	
4	265.6757	47.85	-15.64	32.21	47.00	-14.79	peak	100	169	P	
5	407.5144	47.43	-11.87	35.56	47.00	-11.44	peak	100	96	P	
6	668.1422	43.59	-6.41	37.18	47.00	-9.82	peak	100	140	P	

5. HARMONIC CURRENT EMISSION TEST

5.1. Block Diagram of Test Setup



5.2. Test Standard

EN IEC 61000-3-2:2019+A1:2021

5.3. Operating Condition of EUT

5.3.1 Setup the EUT as shown in Section 5.1.

5.3.2 Turn on the power of all equipments.

5.3.3 Let the EUT work in test mode (ON) and test it.

5.4. Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

5.5. Test Results

PASS

6. VOLTAGE FLUCTUATIONS & FLICKER TEST

6.1. Block Diagram of Test Setup

Same as Section 6.1.

6.2. Test Standard

EN 61000-3-3:2013+A1:2019

6.3. Operating Condition of EUT

Same as Section 5.3. The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

Flicker Test Limit

Test items	Limits
Pst	1.0
dc	3.3%
dmax	4.0%
dt	Not exceed 3.3% for 500ms

6.4. Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

6.5. Test Results

PASS

Please refer to the following page.

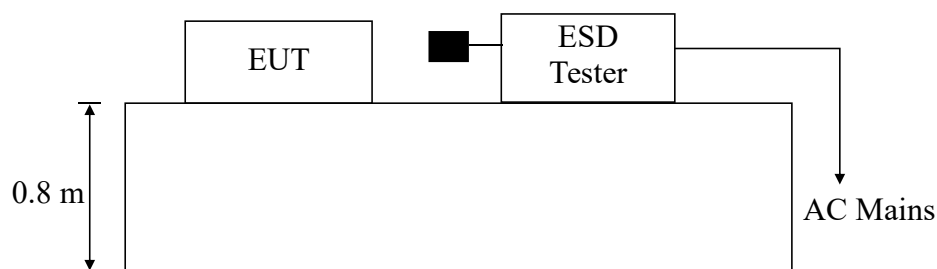
Flicker Test Data			
Temperature:	25.1℃	Relative Humidity:	56%
Pressure:	1008hPa	Phase :	Vertical
Test Voltage :	AC 230V/50Hz	Test Mode:	ON

Voltage Fluctuation	Limit	Value
Relative Voltage Change Characteristic Tmax (dc>3%)	500 ms	0 ms
Maximum Relative Voltage Change dmax	4%	0.00
	6%	/
	7%	/
Relative Steady-state Voltage Change dc	3.3%	0.00

Flicker	Limit	Value
Short-term Flicker Indicator Pst	1.0	0.059
Long-term Flicker Indicator Plt	0.65	/

7. ELECTROSTATIC DISCHARGE IMMUNITY TEST

7.1. Block Diagram of Test Setup



7.2. Test Standard

EN 55035:2017+A11:2020, EN 61000-4-2:2009

Severity Level: 3 / Air Discharge: $\pm 8\text{KV}$

Level: 2 / Contact Discharge: $\pm 4\text{KV}$

7.3. Severity Levels and Performance Criterion

7.3.1 Severity level

Level	Test Voltage Contact Discharge (KV)	Test Voltage Air Discharge (KV)
1.	± 2	± 2
2.	± 4	± 4
3.	± 6	± 8
4.	± 8	± 15
X	Special	Special

7.3.2 Performance criterion : B

- A.** The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- B.** The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- C.** Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

7.4.EUT Configuration

The following equipments are installed on Electrostatic Discharge Immunity test to meet EN 55035:2017+A11:2020, EN 61000-4-2:2009, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.4.

7.5.Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 3.5 except the test setup replaced by Section 7.1.2.

7.6.Test Procedure

7.6.1 Air Discharge:

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

7.6.2 Contact Discharge:

All the procedure shall be same as Section 7.6.1. Except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

7.6.3 Indirect discharge for horizontal coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

7.6.4 Indirect discharge for vertical coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are complete illuminated.

7.7. Test Results

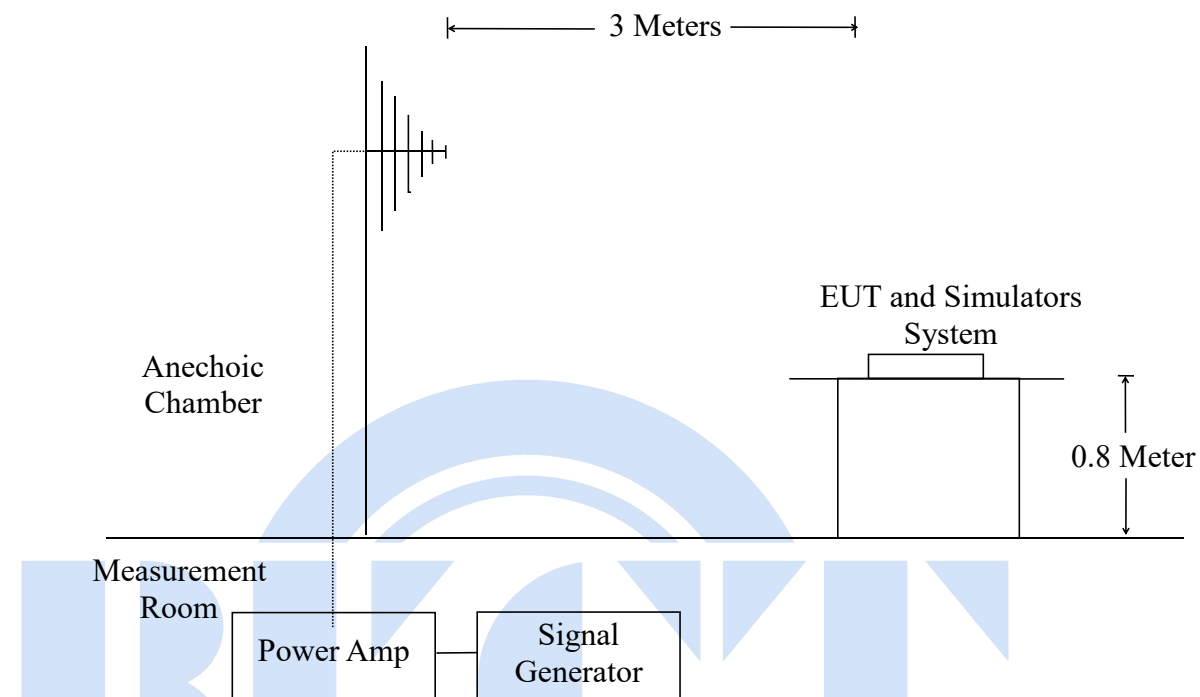
PASS

Please refer to the following page.

ESD Test Data				
Temperature:	25.1℃	Humidity:	54%	
Power Supply :	AC 230V/50Hz	Test Mode:	On	
Air Discharge: ± 8KV Contact Discharge: ± 4KV # For each point positive 25 times and negative 25 times discharge				
Test Points	Air Discharge	Contact Discharge	Performance Criterion	Result
Enclosure	N/A	±2,4 KV	B	PASS
Slit	N/A	±2,4 KV	B	PASS
Screw	N/A	±2,4 KV	B	PASS
Port	N/A	±2,4 KV	B	PASS
VCP	N/A	±2,4 KV	B	PASS
HCP	N/A	±2,4 KV	B	PASS
Note: N/A				

8. RF FIELD STRENGTH SUSCEPTIBILITY TEST

8.1. Block Diagram of Test Setup



8.2. Test Standard

EN 55035:2017+A11:2020, EN IEC 61000-4-3:2020
Severity Level 2, 3V / m

8.3. Severity Levels and Performance Criterion

8.3.1. Severity level

Level	Field Strength V/m
1.	1
2.	3
3.	10
X.	Special

8.3.2. Performance criterion: A

- A、 The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- B、 The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- C、 Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

8.4. EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN 55035:2017+A11:2020, EN 61000-4-4:2012, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test.

Please refer to Section 3.4.

8.5. Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.5 except the test setup replaced by Section 8.1.

8.6. Test Procedure

The EUT and its simulators are placed on a turn table which is 0.8 meter above ground. EUT is set 3 meter away from the transmitting antenna which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna are set on test. Each of the four sides of EUT must be faced this transmitting antenna and measured individually.

All the scanning conditions are as follows :

Condition of Test	Remarks
1. Fielded Strength	3 V/m (Severity Level 2)
2. Radiated Signal	Modulated
3. Scanning Frequency	80 – 1000 MHz
4. Dwell time of radiated	0.0015 decade/s
5. Waiting Time	1 Sec.

8.7. Test Results

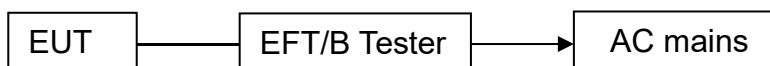
PASS

Please refer to the following page.

R/S Test Data			
Temperature : 25.1℃		Humidity : 53%	
Field Strength: 3 V/m		Criterion: A	
Power Supply: AC 230V/50Hz		Frequency Range: 80 MHz to 1000 MHz	
Modulation: ☒ AM ☐ Pulse ☐ none 1 KHz 80%			
Test Mode : On			
	Frequency Range : 80-1000MHz		
Steps	1 %		
	Horizontal	Vertical	Result
Front	A	A	Pass
Right	A	A	Pass
Rear	A	A	Pass
Left	A	A	Pass
Note: N/A			

9. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST

9.1. Block Diagram of EUT Test Setup



9.2. Test Standard

EN 55035:2017+A11:2020, EN 61000-4-4:2012

9.3. Severity Levels and Performance Criterion

Severity Level 2 at 1KV, Pulse Rise time & Duration: 5 nS / 50 nS

Severity Level:

Open Circuit Output Test Voltage $\pm 10\%$		
Level	On power ports	On I/O(Input/Output) Signal data and control ports
1.	0.5KV	0.25KV
2.	1KV	0.5KV
3.	2KV	1KV
4.	4KV	2KV
X.	Special	Special

Performance criterion: B

- The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

9.4.EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN 55035:2017+A11:2020, EN 61000-4-4:2012, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test. Please refer to Section 3.4.

9.5.Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.6 except the test setup replaced by Section 9.1.

9.6.Test Procedure

EUT shall be placed 0.8m high above the ground reference plane which is a min.1m*1m metallic sheet with 0.65mm minimum thickness. This reference ground plane shall project beyond the EUT by at least 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5m

9.6.1. For input and output AC power ports:

The EUT is connected to the power mains by using a coupling device which couples the EFT interference signal to AC power lines. Both polarities of the test voltage should be applied during compliance test and the duration of the test is 2 minutes.

9.7.Test Results

PASS

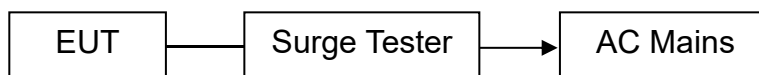
Please refer to the following page.



EFT Test Data				
Temperature:	24.5°C	Humidity:	53%	
Power Supply :	AC 230V/50Hz	Test Mode:	On	
Coupling Line	Test Voltage		Performance Criterion	Result
	±0.5kV	±1kV		
L	±0.5kV	±1kV	B	PASS
N	±0.5kV	±1kV	B	PASS
L-N	±0.5kV	±1kV	B	PASS
PE	±0.5kV	±1kV	B	PASS
L-PE	±0.5kV	±1kV	B	PASS
N-PE	±0.5kV	±1kV	B	PASS
L-N-PE	±0.5kV	±1kV	B	PASS
DC Line	/	/		/
Note: N/A				

10. SURGE TEST

10.1. Block Diagram of EUT Test Setup



10.2. Test Standard

EN 55035:2017+A11:2020, EN 61000-4-5:2014+A1:2017

10.3. Severity Levels and Performance Criterion

Severity Level: Line to Line, Level 2 at 1KV;

Severity Level: Line to Earth, Level 3 at 2KV.

Severity Level	Open-Circuit Test Voltage (KV)
1.	0.5
2.	1.0
3.	2.0
4.	4.0
X.	Special

Performance criterion: B

- A. The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

10.4. EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN 55035:2017+A11:2020, EN 61000-4-5:2014+A1:2017, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 3.4.

10.5. Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.6 except the test setup replaced by Section 10.1.

10.6. Test Procedure

- 1) Set up the EUT and test generator as shown on section 10.1
- 2) For line to line coupling mode, provide a 1KV 1.2/50us voltage surge (at open-circuit condition) and 8/20us current surge to EUT selected points.
- 3) At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are conducted during test.
- 4) Different phase angles are done individually.
- 5) Repeat procedure 2) to 4) except the open-circuit test voltage change from 1KV to 2KV for line to earth coupling mode test.
- 6) Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

10.7. Test Result

PASS

Please refer to the following page.



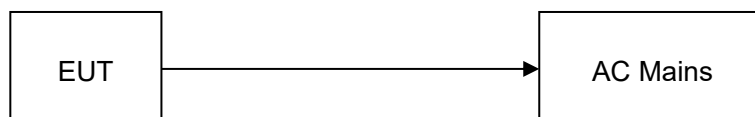
Surge Test Data						
Temperature:	24.5°C		Humidity:	53%		
Power Supply :	AC 230V/50Hz		Test Mode:	On		
Location	Polarity	Phase Angle	No of Pulse	Pulse Voltage (KV)	Performance Criterion	Result
L-N	+	90	5	1	B	Pass
	-	270	5	1		Pass
L-PE	+	90	5	2		Pass
	-	270	5	2		Pass
N-PE	-	90	5	2		Pass
	+	270	5	2		Pass
Signal Line	±			0.5		N/A
Note: N/A						



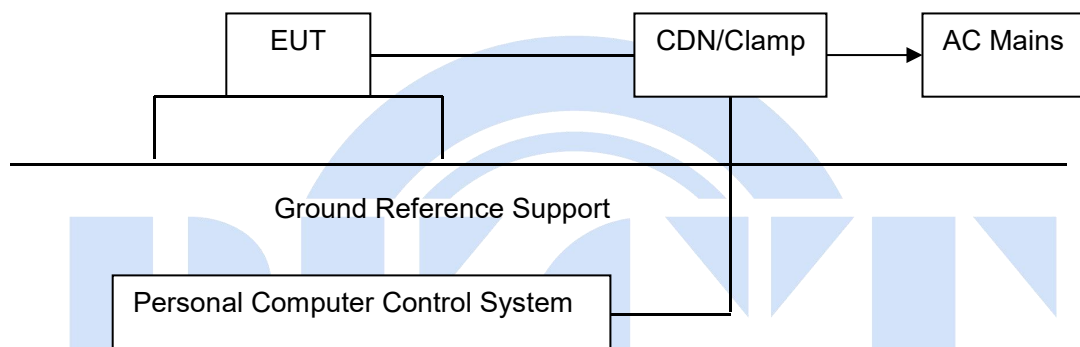
11. INJECTED CURRENTS SUSCEPTIBILITY TEST

11.1. Block Diagram of EUT Test Setup

11.1.1. Block Diagram of EUT Test Setup



11.1.2. Block Diagram of Test Setup



11.2. Test Standard

EN 55035:2017+A11:2020, EN 61000-4-6:2014

11.3. Severity Levels and Performance Criterion

Severity Level 2: 3V(rms), 150KHz ~ 80MHz

Severity Level:

Level	Field Strength V
1.	1
2.	3
3.	10
X.	Special

Performance criterion: A

- A. The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

11.4. EUT Configuration on Test

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.7.

11.5. Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.7 except the test set up replaced as Section 11.1.

11.6. Test Procedure

- 1) Set up the EUT, CDN and test generator as shown on section 11.1
- 2) Let EUT work in test mode and measure.
- 3) The EUT and supporting equipments are placed on an insulating support 0.1m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane at above 0.1-0.3m from EUT. Cables between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 30 and 50 mm (where possible).
- 4) The disturbance signal described below is injected to EUT through CDN.
- 5) The EUT operates within its operational mode(s) under intended climatic conditions after power on.
- 6) The frequency range is swept from 150KHz to 80MHz using 3V signal level, and with the disturbance signal 80% amplitude modulated with a 1KHz sine wave
- 7) The rate of sweep shall not exceed 1.5×10^{-3} decades/s. Where the frequency is swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.

- 8) Recording the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

11.7. Test Result

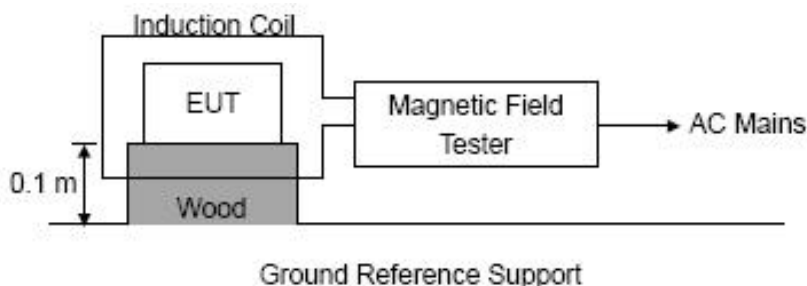
PASS

Please refer to the following page.

CS Test Data						
Temperature:		24.5°C		Humidity:		53%
Power Supply :		AC 230V/50Hz		Test Mode:		On
Frequency Range(MHz)	Injected Position	Strength	Modulation Signal	Freq. Step	Performance Criterion	Result
150KHz ~ 80MHz	AC Line	3V(rms), Unmodulated	AM 80%, 1kHz sine wave	1%	A	Pass
150KHz ~ 80MHz	DC Line	3V(rms), Unmodulated	AM 80%, 1kHz sine wave	1%	/	/
150KHz ~ 80MHz	Signal Line	3V(rms), Unmodulated	AM 80%, 1kHz sine wave	1%	/	/
Note: N/A						

12. MAGNETIC FIELD IMMUNITY TEST

12.1. Block Diagram of Test Setup



12.2. Test Standard

EN 55035:2017+A11:2020, EN 61000-4-8:2010
Severity Level 1 at 1A/m

12.3. Severity Levels and Performance Criterion

12.3.1 Severity level

Level	Magnetic Field Strength A/m
1.	1
2.	3
3.	10
4.	30
5.	100
X.	Special

12.3.2 Performance criterion: B

- The apparatus shall continue to operate as intended during and after the test.
- No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.

D. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

12.4. EUT Configuration on Test

The configuration of EUT is listed in Section 2.8.

12.5. Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.8 except the test set up replaced as Section 12.1.

12.6. Test Procedure

The EUT shall be subjected to the test magnetic field by using the induction coil of standard dimensions (1m*1m) and shown in Section 10.1. The induction coil shall then be rotated by 90° in order to expose the EUT to the test field with different orientations.

12.7. Test Results

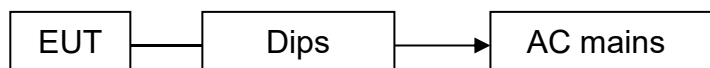
PASS

Please refer to the following page.

MS Test Data					
Temperature:	24.5°C		Humidity:	53%	
Power Supply :	AC 230V/50Hz		Test Mode:	On	
Environmental Phenomena	Test specification	Units	Coil Orientation	Performance Criterion	Result
Magnetic Field	1	A/m	X	A	PASS
			Y	A	PASS
			Z	A	PASS
Note: N/A					

13. VOLTAGE DIPS AND INTERRUPTIONS TEST

13.1. Block Diagram of EUT Test Setup



13.2. Test Standard

EN 55035:2017+A11:2020, EN IEC 61000-4-11:2020

13.3. Severity Levels and Performance Criterion

Severity Level:

Input and Output AC Power Ports.

☒ Voltage Dips.

☒ Voltage Interruptions.

Environmental Phenomena	Test Specification	Units	Performance Criterion
Voltage Dips	>95 0.5	% Reduction period	B
	30 25	% Reduction period	C
Voltage Interruptions	>95 250	% Reduction period	C

Performance criterion: B, C, C

- The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

13.4. EUT Configuration on Test

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.6.

13.5. Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.6 except the test set up replaced as Section 13.1.

13.6. Test Procedure

- 1) Set up the EUT and test generator as shown on section 13.1
- 2) The interruption is introduced at selected phase angles with specified duration. There is a 3mins minimum interval between each test event.
- 3) After each test a full functional check is performed before the next test.
- 4) Repeat procedures 2 & 3 for voltage dips, only the level and duration is changed.
- 5) Record any degradation of performance.

13.7. Test Result

PASS

Please refer to the following page.

DIPS Test Data			
Temperature:	24.5°C	Humidity:	53%
Power Supply :	AC 230V/50Hz	Test Mode:	On
Environmental Phenomena	Test Specification	Units	Performance Criterion
Voltage Dips	>95 0.5	% Reduction period	B
	30 25	% Reduction period	C
Voltage Interruptions	>95 250	% Reduction period	C

14. PHOTOGRAPHS

Photo 1

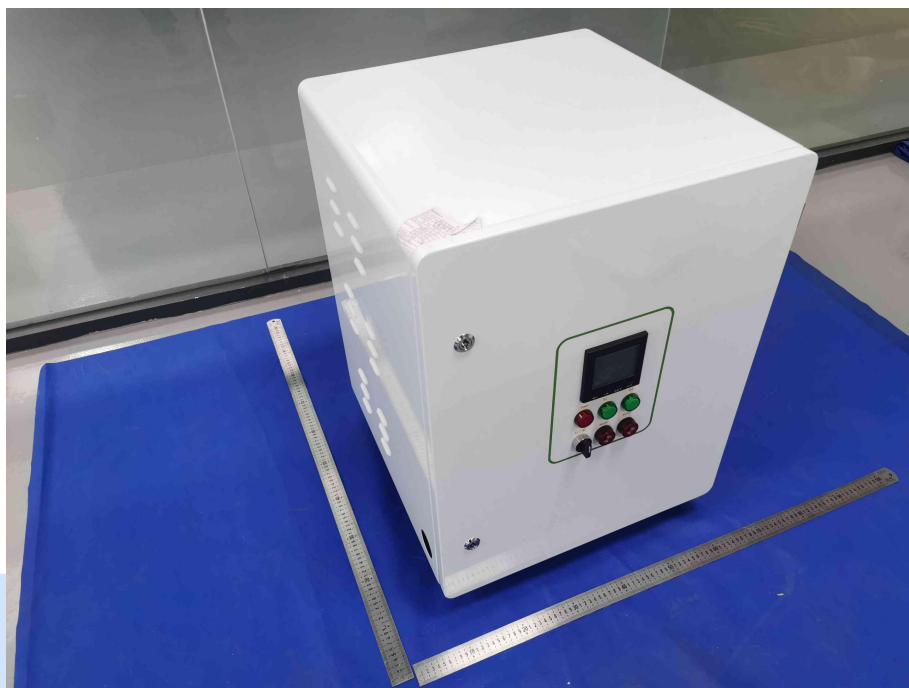


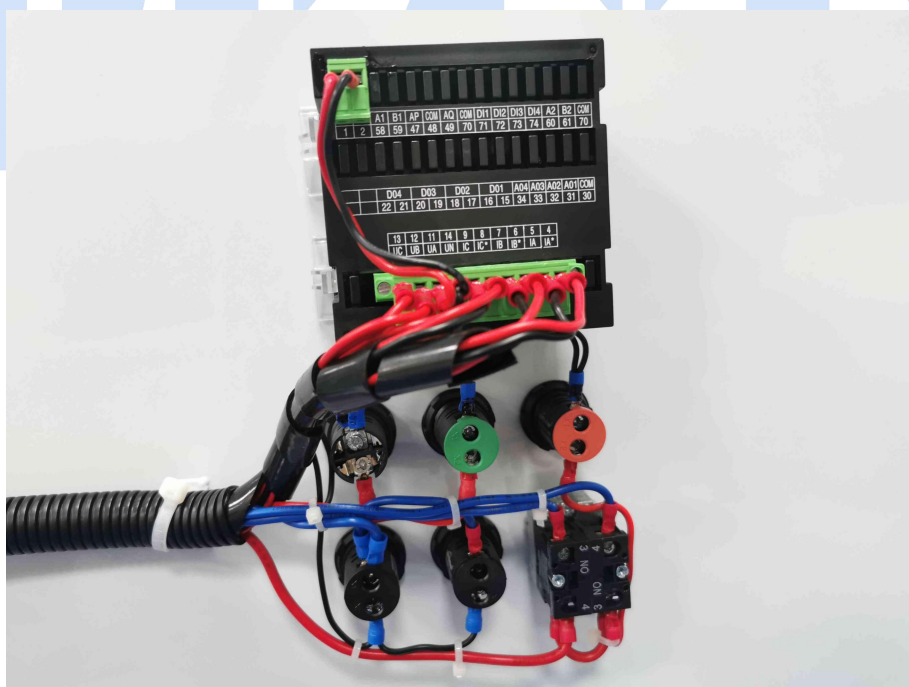
Photo 2



Photo 3



Photo 4



***** END OF REPORT *****